



PART 0 SAR CHAR REPORT

Applicant Name:

Microsoft Corporation
One Microsoft Way
Redmond, WA 98052 USA

Date of Testing:

12/08/2025-01/27/2026

Test Site/Location:

Element Washington DC LLC,
Columbia, MD, USA

Document Serial No.:

1M2511200095-13.C3K

FCC ID:

C3K2085

APPLICANT:

MICROSOFT CORPORATION

Report Type:

Part 0 SAR Characterization

DUT Type:

Portable Computing Device

Model(s):

2085

Permissive Change(s):

Please see change document

Only operations relevant to this permissive change were evaluated for compliance. Please see the original compliance evaluation in RF Exposure Technical Report S/N: 1M231170118-21.C3K for complete evaluation of all other operating modes. The operation description includes a description of all changed items.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Test results reported herein relate only to the item(s) tested.



RJ Ortanez
Executive Vice President



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1 DEVICE UNDER TEST

1.1 Device Overview

This device uses the Qualcomm® FastConnect feature to control and manage transmitting power in real time and to ensure the time-averaged RF exposure is in compliance with the FCC requirement at all times for WLAN operations. Additionally, this device supports BT/NFC technologies, but the output power of these modems is not controlled by the FastConnect algorithm.

Band & Mode	Operating Modes	Tx Frequency
2.4 GHz WIFI	Voice/Data	2412 - 2472 MHz
5 GHz WIFI	Voice/Data	U-NII-1: 5180 - 5240 MHz U-NII-2A: 5260 - 5320 MHz U-NII-2C: 5500 - 5720 MHz U-NII-3: 5745 - 5825 MHz U-NII-4: 5845 - 5885 MHz
6 GHz WIFI	Voice/Data	U-NII-5: 5935 - 6415 MHz U-NII-6: 6435 - 6515 MHz U-NII-7: 6535 - 6875 MHz U-NII-8: 6895 - 7115 MHz
2.4 GHz Bluetooth	Data	2402 - 2480 MHz
NFC	Data	13.56 MHz

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1.2 Time-Averaging for SAR

This device is enabled with Qualcomm® FastConnect algorithm to control and manage transmitting power in real time and to ensure that the time-averaged RF exposure from WLAN is in compliance with FCC requirements. This Part 0 report shows SAR characterization of WLAN radios. Characterization is achieved by determining P_{Limit} for WLAN that corresponds to the exposure design targets after accounting for all device design related uncertainties, i.e., SAR_design_target (< FCC SAR limit). The SAR characterization is denoted as SAR Char in this report. Section 1.3 includes a nomenclature of the specific terms used in this report.

The compliance test under the static transmission scenario and simultaneous transmission analysis are reported in Part 1 report. The validation of the time-averaging algorithm and compliance under the dynamic (time- varying) transmission scenario for WLAN technologies are reported in Part 2 report (report SN could be found in Section 1.4 – Bibliography).

1.3 Nomenclature for Part 0 Report

Technology	Term	Description
WLAN	P_{Limit}	Power level that corresponds to the exposure design target (<i>SAR_design_target</i>) after accounting for all device design related uncertainties
	P_{Max}	Maximum tune up output power
	<i>SAR_design_target</i>	Target SAR level < FCC SAR limit after accounting for all device design related uncertainties
	<i>SAR Char</i>	Table containing P_{limit} for all technologies and bands

1.4 Bibliography

Report Type	Report Serial Number
RF Exposure Part 1 Test Report	1M2511200095-01.C3K
RF Exposure Part 2 Test Report	1M2511200095-16.C3K
RF Exposure Compliance Summary Report	1M2511200095-14.C3K
RF Exposure Part 0 Test Report (Original filing)	1M2311170118-21.C3K
RF Exposure Part 1 Test Report (Original filing)	1M2311170118-01.C3K
RF Exposure Part 2 Test Report (Original filing)	1M2311170118-22.C3K
RF Exposure Compliance Summary Report (Original filing)	1M2311170118-02.C3K

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2 SAR MEASUREMENTS

2.1 SAR Definition

Specific Absorption Rate is defined as the time derivative (rate) of the incremental energy (dU) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dV) of a given density (ρ). It is also defined as the rate of RF energy absorption per unit mass at a point in an absorbing body (see Equation 2-1).

Equation 2-1
SAR Mathematical Equation

$$SAR = \frac{d}{dt} \left(\frac{dU}{dm} \right) = \frac{d}{dt} \left(\frac{dU}{\rho dv} \right)$$

SAR is expressed in units of Watts per Kilogram (W/kg).

$$SAR = \frac{\sigma \cdot E^2}{\rho}$$

where:

σ	=	conductivity of the tissue-simulating material (S/m)
ρ	=	mass density of the tissue-simulating material (kg/m ³)
E	=	Total RMS electric field strength (V/m)

NOTE: The primary factors that control rate of energy absorption were found to be the wavelength of the incident field in relation to the dimensions and geometry of the irradiated organism, the orientation of the organism in relation to the polarity of field vectors, the presence of reflecting surfaces, and whether conductive contact is made by the organism with a ground plane.[6]

2.2 SAR Measurement Procedure

The evaluation was performed using the following procedure compliant to FCC KDB Publication 865664 D01v01r04 and IEEE 1528-2013:

1. The SAR distribution at the exposed side of the head or body was measured at a distance no greater than 5.0 mm from the inner surface of the shell. The area covered the entire dimension of the device-head and body interface and the horizontal grid resolution was determined per FCC KDB Publication 865664 D01v01r04 (See Table 2-1) and IEEE 1528-2013.
2. The point SAR measurement was taken at the maximum SAR region determined from Step 1 to enable the monitoring of SAR fluctuations/drifts during the 1g/10g cube evaluation. SAR at this fixed point was measured and used as a reference value.
3. Based on the area scan data, the peak of the region with maximum SAR was determined by spline interpolation. Around this point, a volume was assessed according to the measurement resolution and volume size requirements of FCC KDB Publication 865664 D01v01r04 (See Table 2-1) and IEEE 1528-2013. On the basis

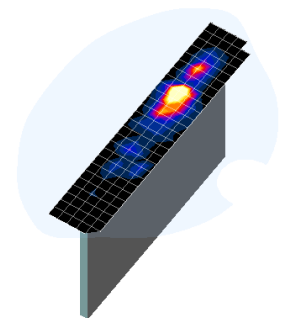


Figure 2-1
Sample SAR Area Scan

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of this data set, the spatial peak SAR value was evaluated with the following procedure (see references or the DASY manual online for more details):

- a. SAR values at the inner surface of the phantom are extrapolated from the measured values along the line away from the surface with spacing no greater than that in Table 2-1. The extrapolation was based on a least-squares algorithm. A polynomial of the fourth order was calculated through the points in the z-axis (normal to the phantom shell).
 - b. After the maximum interpolated values were calculated between the points in the cube, the SAR was averaged over the spatial volume (1g or 10g) using a 3D-Spline interpolation algorithm. The 3D-spline is composed of three one-dimensional splines with the “Not a knot” condition (in x, y, and z directions). The volume was then integrated with the trapezoidal algorithm. One thousand points (10 x 10 x 10) were obtained through interpolation, in order to calculate the averaged SAR.
 - c. All neighboring volumes were evaluated until no neighboring volume with a higher average value was found.
4. The SAR reference value, at the same location as step 2, was re-measured after the zoom scan was complete to calculate the SAR drift. If the drift deviated by more than 5%, the SAR test and drift measurements were repeated.

Table 2-1
Area and Zoom Scan Resolutions per FCC KDB Publication 865664 D01v01r04*

Frequency	Maximum Area Scan Resolution (mm) ($\Delta x_{\text{area}}, \Delta y_{\text{area}}$)	Maximum Zoom Scan Resolution (mm) ($\Delta x_{\text{zoom}}, \Delta y_{\text{zoom}}$)	Maximum Zoom Scan Spatial Resolution (mm)			Minimum Zoom Scan Volume (mm) (x,y,z)
			Uniform Grid	Graded Grid		
				$\Delta z_{\text{zoom}}(n)$	$\Delta z_{\text{zoom}}(1)^*$	
≤ 2 GHz	≤ 15	≤ 8	≤ 5	≤ 4	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 30
2-3 GHz	≤ 12	≤ 5	≤ 5	≤ 4	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 30
3-4 GHz	≤ 12	≤ 5	≤ 4	≤ 3	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 28
4-5 GHz	≤ 10	≤ 4	≤ 3	≤ 2.5	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 25
5-6 GHz	≤ 10	≤ 4	≤ 2	≤ 2	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 22

*Also compliant to IEEE 1528-2013 Table 6

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3 SAR CHARACTERIZATION

3.1 DSI and SAR Determination

This device uses different Device State Index (DSI) to configure different time averaged power levels based on certain exposure scenarios. Depending on the detection scheme implemented in the smartphone, the worst-case SAR was determined by measurements for the relevant exposure conditions for that DSI. Detailed descriptions of the detection mechanisms are included in the operational description.

When 1g SAR exposure comparison is needed, the worst-case was determined from SAR normalized to 1g SAR limit.

The device state index (DSI) conditions used in Table 3-1 represent different exposure scenarios.

Table 3-1
DSI and Corresponding Exposure Scenarios

Scenario	Description	SAR Test Cases
No Motion and/or with keyboard (DSI=0)	Device detects this DSI when keyboard accessory is attached and at an angle $\leq 210^\circ$ or no motion is detected	KDB Publication 616217 D04v01r02
Motion (DSI=1)	Device detects this DSI when motion is detected and no keyboard accessory is attached or keyboard accessory is attached at $>210^\circ$ angle	KDB Publication 648474 D04v01r03

3.2 SAR Design Target

SAR_design_target is determined by ensuring that it is less than FCC SAR limit after accounting for total device designed related uncertainties specified by the manufacturer (see Table 3-2).

Table 3-2
***SAR_design_target* Calculations**

<i>SAR_design_target</i>	
$SAR_design_target < SAR_regulatory_limit \times 10^{\frac{-Total\ Uncertainty}{10}}$	
1g SAR (W/kg)	
<i>Total Uncertainty</i>	1.0 dB
<i>SAR_regulatory_limit</i>	1.6 W/kg
<i>SAR_design_target</i>	1.0 W/kg

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3.3 SAR Char

SAR test results corresponding to P_{Max} for each antenna/technology/band/DSI can be found in the SAR Part 1 Evaluation Report (report SN could be found in Section 1.4 – Bibliography).

P_{Limit} is calculated by linearly scaling with the measured SAR at the P_{part0} to correspond to the SAR_{design_target} . When $P_{Limit} < P_{Max}$, P_{part0} was used as P_{Limit} in the Smart Transmit EFS. When $P_{Limit} > P_{Max}$ and $P_{part0} = P_{Max}$, calculated P_{Limit} was used in the Smart Transmit EFS. All reported SAR obtained from the P_{part0} SAR tests was less than $SAR_{Design_target} + 1$ dB Uncertainty. The final P_{Limit} determination for each exposure scenario corresponding to SAR_{design_target} are shown in Table 3-3.

Table 3-3
 P_{Limit} Determination

Device State Index (DSI)	P_{Limit} Determination Scenarios
0	P_{Limit} is calculated based on 1g Body SAR at 0 mm for bottom edge with keyboard accessory attached and 1g Body SAR when no motion is detected for back, top, right, and left edges at 25mm
1	P_{Limit} is calculated based on 1g Body Tablet SAR at 0 mm for back, top, bottom, right, and left surfaces with and without keyboard accessory.

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Table 3-4
SAR Characterizations

			Maximum Tune-Up Output Power*	Body
Exposure Scenario				1g
Averaging Volume				0mm
Spacing				1
DSI				
Technology/Band	Antenna	Antenna Group	P _{max}	P _{limit}
2.4 GHz WIFI	R	AG0	20.0	17.25
2.4 GHz WIFI	L	AG1	20.0	17.25
5 GHz WIFI UNII-1	R	AG0	16.5	15.75
5 GHz WIFI UNII-1	L	AG1	16.5	16.25
5 GHz WIFI UNII-2A	R	AG0	16.5	15.25
5 GHz WIFI UNII-2A	L	AG1	16.5	16.25
5 GHz WIFI UNII-2C	R	AG0	17.0	14.50
5 GHz WIFI UNII-2C	L	AG1	17.0	14.00
5 GHz WIFI UNII-3	R	AG0	19.5	14.00
5 GHz WIFI UNII-3	L	AG1	19.5	14.00
5 GHz WIFI UNII-4	R	AG0	16.5	14.00
5 GHz WIFI UNII-4	L	AG1	16.5	13.75
6 GHz WIFI UNII-5	R	AG0	16.5	12.75
6 GHz WIFI UNII-5	L	AG1	16.5	13.25
6 GHz WIFI UNII-6	R	AG0	7.5	7.50
6 GHz WIFI UNII-6	L	AG1	7.5	7.50
6 GHz WIFI UNII-7	R	AG0	17.0	12.75
6 GHz WIFI UNII-7	L	AG1	17.0	13.75
6 GHz WIFI UNII-8	R	AG0	7.5	7.50
6 GHz WIFI UNII-8	L	AG1	7.5	7.50

Notes:

1. When $P_{Max} < P_{Limit}$, the DUT will operate at a power level up to P_{Max} .
2. MIMO is not included in SAR CHAR due to the two antennas being in separate Antenna Groups.

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4 EQUIPMENT LIST

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
Agilent	N5182A	MXG Vector Signal Generator	5/30/2025	Annual	5/30/2026	MY48180366
Agilent	N5182A	MXG Vector Signal Generator	8/1/2025	Annual	8/1/2026	MY47420651
Anritsu	MS2038C	20 GHz Network Analyzer	5/14/2025	Annual	5/14/2026	1214109
Agilent	N4010A	Wireless Connectivity Test Set	N/A	N/A	N/A	GB46170464
Amplifier Research	15S1G6	Amplifier	CBT	N/A	CBT	433974
Anritsu	MN8110B	I/O Adaptor	CBT	N/A	CBT	6261747881
Rohde & Schwarz	NRP2	Power Meter	5/23/2025	Annual	5/23/2026	103084
Anritsu	MA24106A	USB Power Sensor	5/29/2025	Annual	5/29/2026	1344554
Anritsu	MA24106A	USB Power Sensor	6/26/2025	Annual	6/26/2026	1827529
Control Company	4052	Long Stem Thermometer	2/27/2024	Biennial	2/27/2026	240174346
Control Company	4052	Long Stem Thermometer	2/27/2024	Biennial	2/27/2026	240171096
Control Company	4052	Long Stem Thermometer	2/27/2024	Biennial	2/27/2026	240171059
Control Company	4040	Therm./ Clock/ Humidity Monitor	4/15/2024	Biennial	4/15/2026	240310280
Control Company	4040	Therm./ Clock/ Humidity Monitor	10/15/2024	Biennial	10/15/2026	240763503
Testo	ALARM-HYGROMETER	ALARM-HYGROMETER	7/3/2025	Annual	7/3/2026	83316952
Testo	ALARM-HYGROMETER	ALARM-HYGROMETER	7/3/2025	Annual	7/3/2026	83316953
Testo	ALARM-HYGROMETER	ALARM-HYGROMETER	7/3/2025	Annual	7/3/2026	83316970
Keysight Technologies	N9020A	MXA Signal Analyzer	9/15/2025	Annual	9/15/2026	MY48010233
MCL	BW-N6W5+	6dB Attenuator	CBT	N/A	CBT	1139
MCL	BW-N3W5+	3dB Attenuator	CBT	N/A	CBT	2028
Mini-Circuits	VLF-6000+	Low Pass Filter DC to 6000 MHz	CBT	N/A	CBT	N/A
Mini-Circuits	VLF-6000+	Low Pass Filter DC to 6000 MHz	CBT	N/A	CBT	31634
Mini-Circuits	BW-N20W5+	DC to 18 GHz Precision Fixed 20 dB Attenuator	CBT	N/A	CBT	N/A
Mini-Circuits	NLP-1200+	Low Pass Filter DC to 1000 MHz	CBT	N/A	CBT	N/A
Mini-Circuits	NLP-2950+	Low Pass Filter DC to 2700 MHz	CBT	N/A	CBT	N/A
Mini-Circuits	BW-N20W5	Power Attenuator	CBT	N/A	CBT	1226
Mini-Circuits	ZUDC10-83-S+	Directional Coupler	CBT	N/A	CBT	2050
Narda	4772-3	Attenuator (3dB)	CBT	N/A	CBT	9406
Narda	BW-S3W2	Attenuator (3dB)	CBT	N/A	CBT	120
Seekonk	NC-100	Torque Wrench	4/2/2024	Biennial	4/2/2026	1262
SPEAG	DAK-3.5	Dielectric Assessment Kit	11/10/2025	Annual	11/10/2026	1277
SPEAG	DAK-3.5	Dielectric Assessment Kit	8/5/2025	Annual	8/6/2026	1041
SPEAG	DAK-3.5	Dielectric Assessment Kit	7/14/2025	Annual	7/14/2026	1039
SPEAG	MAIA	Modulation and Audio Interference Analyzer	N/A	N/A	N/A	1237
SPEAG	MAIA	Modulation and Audio Interference Analyzer	N/A	N/A	N/A	1331
SPEAG	MAIA	Modulation and Audio Interference Analyzer	N/A	N/A	N/A	1390
SPEAG	D2450V2	2450 MHz SAR Dipole	10/7/2025	Annual	10/7/2026	797
SPEAG	D5GHzV2	5 GHz SAR Dipole	2/21/2024	Biennial	2/21/2027	1057
SPEAG	D6.5GHzV2	6.5 GHz SAR Dipole	12/5/2025	Annual	12/5/2026	1018
SPEAG	5G Verification Source 10GHz	10GHz System Verification Antenna	3/4/2025	Annual	3/4/2026	1002
SPEAG	DAE4	Dasy Data Acquisition Electronics	3/11/2025	Annual	3/11/2026	1415
SPEAG	DAE4	Dasy Data Acquisition Electronics	12/3/2025	Annual	12/3/2026	1213
SPEAG	DAE4	Dasy Data Acquisition Electronics	6/5/2025	Annual	6/5/2026	1558
SPEAG	DAE4ip	Dasy Data Acquisition Electronics	2/7/2025	Annual	2/7/2026	1638
SPEAG	EUmmWV3	EUmmWV3 Probe	3/12/2025	Annual	3/12/2026	9421
SPEAG	EX3DV4	SAR Probe	3/7/2025	Annual	3/7/2026	7488
SPEAG	EX3DV4	SAR Probe	6/11/2025	Annual	6/11/2026	7661
SPEAG	EX3DV4	SAR Probe	2/10/2025	Annual	2/10/2026	7570

Note:

1. CBT (Calibrated Before Testing). Prior to testing, the measurement paths containing a cable, amplifier, attenuator, coupler or filter were connected to a calibrated source (i.e. a signal generator) to determine the losses of the measurement path. The power meter offset was then adjusted to compensate for the measurement system losses. This level offset is stored within the power meter before measurements are made. This calibration verification procedure applies to the system verification and output power measurements. The calibrated reading is then taken directly from the power meter after compensation of the losses for all final power measurements.
2. Each equipment item was used solely within its respective calibration period.

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5 MEASUREMENT UNCERTAINTIES

For SAR Measurements

SAR Uncertainty Budget based on IEEE 1528-2013 (0.3 GHz to 10 GHz)

a	b	c	d	e f(d,k)	f	g	h cx/f/e	i cxg/e	k
Uncertainty component	Reference	Tol. (± %)	Prob. dist.	Dvi.	ci (1g)	ci (10g)	lg ui (± %)	10g ui (± %)	vi
Measurement system									
Probe calibration	E.2.1	9.30	N	1	1	1	9.30	9.30	∞
Axial isotropy	E.2.2	0.25	N	1	0.707	0.707	0.18	0.18	∞
Hemispherical isotropy	E.2.2	1.30	N	1	0.707	0.707	0.92	0.92	∞
Boundary effect	E.2.3	2.00	R	1.73	1	1	1.15	1.15	∞
Linearity	E.2.4	0.30	R	1.73	1	1	0.17	0.17	∞
System detection limits	E.2.4	0.25	R	1.73	1	1	0.14	0.14	∞
Modulation response	E.2.5	4.80	R	1.73	1	1	2.77	2.77	∞
Readout electronics	E.2.6	0.30	N	1	1	1	0.30	0.30	∞
Response time	E.2.7	1.01	R	1.73	1	1	0.58	0.58	∞
Integration time	E.2.8	2.60	R	1.73	1	1	1.50	1.50	∞
RF ambient conditions - noise	E.6.1	3.00	R	1.73	1	1	1.73	1.73	∞
RF ambient conditions - reflections	E.6.1	3.00	R	1.73	1	1	1.73	1.73	∞
Probe positioner mechanical tolerance	E.6.2	0.04	R	1.73	1	1	0.02	0.02	∞
Probe positioning with respect to phantom shell	E.6.3	0.80	R	1.73	1	1	0.46	0.46	∞
Extrapolation, interpolation, and integration algorithms for max. SAR evaluation	E.5	4.00	R	1.73	1	1	2.31	2.31	∞
Test sample related									
Test sample positioning	E.4.2	3.12	N	1	1	1	3.12	3.12	35
Device holder uncertainty	E.4.1	1.67	N	1	1	1	1.67	1.67	5
Output power variation - SAR drift	E.2.9	5.00	R	1.73	1	1	2.89	2.89	∞
SAR scaling	E.6.5	0.00	R	1.73	1	1	0.00	0.00	∞
Phantom and tissue parameters									
Phantom shell uncertainty - shape, thickness and permittivity	E.3.1	7.60	R	1.73	1	1	4.39	4.39	∞
Uncertainty in SAR correction for deviations in permittivity and conductivity	E.3.2	0.00	N	1	1	1	0.00	0.00	∞
Liquid conductivity measurement	E.3.3	4.27	N	1	0.78	0.71	3.33	3.03	55
Liquid permittivity measurement	E.3.3	4.18	N	1	0.23	0.26	0.96	1.09	55
Liquid conductivity - temperature uncertainty	E.3.4	3.40	R	1.73	0.78	0.71	1.53	1.39	∞
Liquid permittivity - temperature uncertainty	E.3.4	0.60	R	1.73	0.23	0.26	0.08	0.09	∞
Liquid Conductivity - deviation from target values	E.3.2	5.00	R	1.73	0.64	0.43	1.85	1.24	∞
Liquid Permittivity - deviation from target values	E.3.2	5.00	R	1.73	0.60	0.49	1.73	1.41	∞
Combined standard uncertainty							13.1	12.9	150
Expanded uncertainty (95% confidence interval)							26.2	25.8	

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Applicable for Power Density Measurements:

a	b	c	d	e	f = c x f/e	g
Uncertainty Component	Unc. (± dB)	Prob. Dist.	Div.	c _i	u _i (± dB)	v _i
Measurement System						
Calibration	0.49	N	1	1	0.49	∞
Probe Correction	0.00	R	1.73	1	0.00	∞
Frequency Response	0.20	R	1.73	1	0.12	∞
Sensor Cross Coupling	0.00	R	1.73	1	0.00	∞
Isotropy	0.50	R	1.73	1	0.29	∞
Linearity	0.20	R	1.73	1	0.12	∞
Probe Scattering	0.00	R	1.73	1	0.00	∞
Probe Positioning offset	0.30	R	1.73	1	0.17	∞
Probe Positioning Repeatability	0.04	R	1.73	1	0.02	∞
Sensor Mechanical Offset	0.00	R	1.73	1	0.00	∞
Probe Spatial Resolution	0.00	R	1.73	1	0.00	∞
Field Impedance Dependence	0.00	R	1.73	1	0.00	∞
Amplitude and Phase Drift	0.00	R	1.73	1	0.00	∞
Amplitude and Phase Noise	0.04	R	1.73	1	0.02	∞
Measurement Area Truncation	0.00	R	1.73	1	0.00	∞
Data Acquisition	0.03	N	1	1	0.03	∞
Sampling	0.00	R	1.73	1	0.00	∞
Field Reconstruction	2.00	R	1.73	1	1.15	∞
Forward Transformation	0.00	R	1.73	1	0.00	∞
Power Density Scaling	0.00	R	1.73	1	0.00	∞
Spatial Averaging	0.10	R	1.73	1	0.06	∞
System Detection Limit	0.04	R	1.73	1	0.02	∞
Test Sample Related						
Probe Coupling with DUT	0.00	R	1.73	1	0.00	∞
Modulation Response	0.40	R	1.73	1	0.23	∞
Integration Time	0.00	R	1.73	1	0.00	∞
Response Time	0.00	R	1.73	1	0.00	∞
Device Holder Influence	0.10	R	1.73	1	0.06	∞
DUT alignment	0.00	R	1.73	1	0.00	∞
RF Ambient Conditions	0.04	R	1.73	1	0.02	∞
Ambient Reflections	0.04	R	1.73	1	0.02	∞
Immunity/Secondary Reception	0.00	R	1.73	1	0.00	∞
Drift of DUT	0.21	R	1.73	1	0.12	∞
Combined Standard Uncertainty (k=1)					RSS	1.34
Expanded Uncertainty (95% CONFIDENCE LEVEL)					k=2	2.68

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